Se	arch No	tes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/686,130	INOKUCHI, HIROYUKI
Examiner	Art Unit
Khanh V. Nguyen	2817

	SEAR	CHED	
Class	Subclass	Date	Examiner
			-
,			-
		-	-
-			
	,		
<u> </u>			
			

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
	:		
	ch History tout	07/18/06	NKV

SEARCH (INCLUDING SEAR		')
	DATE	EXMR
330/69,252,253,259,260 + keywords	1/5/2005 (07/18/06)	NKV (NKV)